

# ISO/IEC 30193:2013-07 (E)

## Information technology - Digitally recorded media for information interchange and storage - 120 mm Triple Layer (100,0 Gbytes per disk) BD Rewritable disk

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<b>Contents</b>		<b>Page</b>
Foreword .....		x
Introduction .....		x
1	Scope .....	1
2	Conformance .....	1
2.1	Optical Disk .....	1
2.2	Generating system .....	1
2.3	Receiving system .....	2
2.4	Compatibility statement .....	2
3	Normative References .....	2
4	Terms and definitions .....	2
5	Conventions and notations .....	7
5.1	Terminology: .....	7
5.1.1	Meaning of words .....	7
5.1.2	Levels of grouping .....	7
5.2	Representation of numbers .....	7
5.3	Integer calculus .....	8
5.4	Names .....	8
6	List of acronyms .....	9
7	General description of disk .....	11
8	General requirements .....	12
8.1	Environments .....	12
8.1.1	Test environment .....	12
8.1.2	Operating environment .....	12
8.1.3	Storage environment .....	13
8.1.4	Transportation .....	14
8.2	Safety requirements .....	14
8.3	Flammability .....	14
9	Reference drive .....	14
9.1	General .....	14
9.2	Measurement conditions .....	14
9.3	Optical system .....	14
9.4	Optical beam .....	15
9.5	HF read channel .....	16
9.6	Radial PP read channel .....	16
9.7	Disk Clamping .....	16
9.8	Rotation of disk and Measurement Velocity .....	17
9.9	Normalized servo transfer function .....	17
9.10	Measurement Velocities and Reference servos for axial tracking .....	18
9.10.1	General .....	18
9.10.2	Reference servo for axial tracking .....	18
9.11	Measurement Velocities and Reference servos for radial tracking .....	19

9.11.1	General .....	19
9.11.2	Reference servo for radial tracking .....	19
10	Dimensional characteristics .....	20
10.1	General .....	20
10.2	Disk reference planes and reference axis .....	21
10.3	Overall dimensions .....	22
10.4	First transition Area .....	22
10.5	Protection ring .....	22
10.6	Clamping Zone .....	23
10.7	Second transition Area .....	23
10.8	Information Area .....	23
10.8.1	General .....	23
10.8.2	Subdivision of Information Zone on TL disk .....	24
10.9	Rim Area .....	25
11	Mechanical characteristics .....	26
11.1	Mass .....	26
11.2	Moment of inertia .....	26
11.3	Dynamic imbalance .....	26
11.4	Axial runout .....	26
11.4.1	General .....	26
11.4.2	Residual axial tracking error .....	26
11.5	Radial runout .....	26
11.5.1	General .....	26
11.5.2	Residual radial tracking error .....	27
11.6	Durability of Cover Layer .....	27
11.6.1	Impact resistance of Cover Layer .....	27
11.6.2	Scratch resistance of Cover Layer .....	27
11.6.3	Repulsion of fingerprints by Cover Layer .....	27
12	Optical characteristics in Information Area .....	27
12.1	General .....	27
12.2	Refractive index of Transmission Stacks (TS) .....	27
12.3	Thickness of Transmission Stacks (TS) .....	28
12.4	Example of target thickness of Spacer Layers for TL disks .....	29
12.5	Reflectivity of Recording Layers .....	31
12.6	Birefringence .....	31
12.7	Angular deviation .....	31
13	Data Format .....	33
13.1	General .....	33
13.2	Data Frame .....	35
13.3	Error-Detection Code (EDC) .....	35
13.4	Scrambled Data Frame .....	35
13.5	Data Block .....	36
13.6	LDC Block .....	37
13.7	LDC code words .....	37
13.8	LDC Cluster .....	38
13.8.1	General .....	38
13.8.2	First interleaving step .....	38
13.8.3	Second interleaving step .....	39
13.9	Addressing and Control Data .....	41
13.9.1	General .....	41
13.9.2	Address Units .....	41
13.9.3	User-Control Data .....	45
13.9.4	Byte/Bit assignment for User-Control Data .....	45
13.10	Access Block .....	47
13.11	BIS Block .....	47
13.12	BIS code words .....	48
13.13	BIS Cluster .....	48
13.14	ECC Cluster .....	51

13.15	Recording Frames .....	51
13.16	Physical Cluster .....	52
13.17	17PP Modulation for Recordable data .....	52
13.17.1	General .....	52
13.17.2	Bit conversion rules .....	52
13.17.3	dc-control procedure .....	53
13.17.4	Frame Sync .....	53
13.18	Modulation and NRZI conversion .....	55
14	Physical Data Allocating and Linking .....	55
14.1	General .....	55
14.2	Recording-Unit Block (RUB) .....	55
14.2.1	General .....	55
14.2.2	Data Run-in .....	56
14.2.3	Data Run-out .....	57
14.2.4	Guard_3 field .....	58
14.3	Locating data relative to wobble addresses .....	58
14.3.1	General .....	58
14.3.2	Start-Position Shift (SPS) .....	58
15	Track format .....	60
15.1	General .....	60
15.2	Track shape .....	60
15.3	Track path .....	62
15.4	Track Pitch .....	62
15.4.1	Track Pitch in BCA Zone .....	62
15.4.2	Track Pitch in Embossed HFM Areas .....	62
15.4.3	Track Pitch in Rewritable Areas .....	62
15.4.4	Track Pitch between Embossed HFM Area and Rewritable Area .....	63
15.5	Track layout of HFM Grooves .....	63
15.5.1	General .....	63
15.5.2	Data Format .....	63
15.5.3	Addressing and Control Data .....	64
15.5.4	Recording Frames .....	67
15.6	Track layout of Wobbled Grooves .....	69
15.6.1	General .....	69
15.6.2	Modulation of wobbles .....	69
15.6.3	Wobble polarity .....	70
15.7	ADIP information .....	71
15.7.1	General .....	71
15.7.2	ADIP-Unit Types .....	71
15.7.3	ADIP word structure .....	72
15.7.4	ADIP data structure .....	73
15.7.5	ADIP error correction .....	76
15.8	Disk Information in ADIP Aux Frame .....	78
15.8.1	General .....	78
15.8.2	Error protection for Disk Information Aux Frames .....	78
15.8.3	Disk-Information data structure .....	79
16	General description of Information Zone .....	122
16.1	General .....	122
16.2	Format of Information Zone .....	122
17	Layout of Rewritable Area of Information Zone .....	122
18	Inner Zone .....	127
18.1	General .....	127
18.2	Permanent Information & Control data (PIC) Zone .....	130
18.2.1	General .....	130
18.2.2	Content of PIC Zone .....	131
18.2.3	Emergency Brake .....	132
18.3	Rewritable Area of Inner Zone(s) .....	133

18.3.1	Protection-Zone 2 .....	133
18.3.2	Buffer .....	133
18.3.3	INFO 2 / Reserved 8 .....	133
18.3.4	INFO 2 / Reserved 7 .....	134
18.3.5	INFO 2 / Reserved 6 .....	134
18.3.6	INFO 2 / Reserved 5 .....	134
18.3.7	INFO2 / PAC 2 .....	134
18.3.8	INFO2 / Reserved .....	134
18.3.9	INFO2 / DMA 2 .....	134
18.3.10	INFO2 / Control Data 2 .....	134
18.3.11	INFO2 / Buffer 2 .....	134
18.3.12	OPC / Test Zone .....	134
18.3.13	Reserved .....	134
18.3.14	INFO1 / Buffer 1 .....	135
18.3.15	INFO1 / Drive Area (optional) .....	135
18.3.16	INFO1 / Reserved 3 .....	136
18.3.17	INFO1 / Reserved 2 .....	136
18.3.18	INFO1 / Reserved 1 .....	136
18.3.19	INFO1 / DMA 1 .....	136
18.3.20	INFO1 / Control Data 1 .....	136
18.3.21	INFO1 / PAC 1 .....	136
18.3.22	INFO1 / Reserved .....	137
19	Data Zone .....	137
20	Outer Zone(s) .....	137
20.1	General .....	137
20.2	INFO3 / Buffer 3 .....	138
20.3	INFO3 / DMA 3 .....	138
20.4	INFO3 / Control Data 3 .....	138
20.5	Angular buffer .....	138
20.6	INFO4 / DMA 4 .....	138
20.7	INFO4 / Control Data 4 .....	138
20.8	INFO4 / Buffer 4 .....	138
20.9	DCZ0 / Test Zone, DCZ1 / Test Zone and DCZ2 / Test Zone .....	138
20.10	Protection-Zone 3 .....	138
21	Physical-Access Control Clusters .....	138
21.1	General .....	138
21.2	Layout of PAC Zones .....	139
21.3	General structure of PAC Clusters .....	140
21.4	Primary PAC Cluster (mandatory) .....	144
21.5	Disk Write-Protect PAC Cluster (optional) .....	147
21.6	IS1 and IS2 PAC Clusters .....	151
22	Disk Management .....	153
22.1	General .....	153
22.2	Disk-Management Structure (DMS) .....	154
22.2.1	General .....	154
22.2.2	Disk-Definition Structure (DDS) .....	156
22.2.3	Defect List (DFL) .....	160
23	Assignment of Logical-Sector Numbers (LSNs) .....	165
24	Characteristics of Grooved Areas .....	167
25	Method of testing for Grooved Area .....	167
25.1	General .....	167
25.2	Environment .....	167
25.3	Reference drive .....	167
25.3.1	General .....	167
25.3.2	Read power .....	167

25.3.3	Read channels .....	167
25.3.4	Tracking requirements .....	167
25.3.5	Scanning velocities .....	168
25.4	Definition of signals .....	168
26	Signals from HFM Grooves .....	169
26.1	Push-Pull polarity .....	169
26.2	Push-Pull signal .....	169
26.3	Wobble signal .....	169
26.4	Jitter of HFM signal .....	169
27	Signals from Wobbled Grooves .....	170
27.1	Phase depth .....	170
27.2	Push-Pull signal .....	170
27.3	Wobble signal .....	170
27.3.1	General .....	170
27.3.2	Measurement of NWS .....	170
27.3.3	Measurement of the wobble CNR .....	171
27.3.4	Measurement of harmonic distortion of wobble .....	171
28	Characteristics of Recording Layer .....	171
29	Method of testing for Recording Layer .....	171
29.1	General .....	171
29.2	Environment .....	171
29.3	Reference drive .....	171
29.3.1	General .....	171
29.3.2	Read power .....	172
29.3.3	Read channels .....	172
29.3.4	Tracking requirements .....	172
29.3.5	Scanning velocities .....	172
29.4	Write conditions .....	172
29.4.1	Write-pulse waveform .....	172
29.4.2	Write powers .....	172
29.4.3	Average power .....	173
29.4.4	Write conditions for i-MLSE measurement .....	173
29.4.5	Write conditions for cross-erase measurements .....	173
29.5	Definition of signals .....	173
30	Signals from Recorded Areas .....	174
30.1	HF signals .....	174
30.2	Modulated amplitude .....	174
30.3	Reflectivity-Modulation product .....	175
30.4	Asymmetry .....	176
30.5	i-MLSE@DOW(n) .....	176
30.6	Cross-erase @ DOW(n)XE .....	176
30.7	Read stability .....	177
31	Local defects .....	177
32	Characteristics of User Data .....	178
33	Method of testing for User Data .....	178
33.1	General .....	178
33.2	Environment .....	178
33.3	Reference drive .....	178
33.3.1	General .....	178
33.3.2	Read power .....	178
33.3.3	Read channels .....	178
33.3.4	Error correction .....	178
33.3.5	Tracking requirements .....	178
33.3.6	Scanning velocities .....	178

33.4	Definition of signals .....	179
34	Minimum quality of recorded information .....	180
34.1	General .....	180
34.2	Random Symbol Error Rate .....	180
34.3	Maximum burst errors .....	180
34.4	User-written Data .....	180
35	BCA .....	180
Annex A (normative) Thickness of Transmission Stacks in case of multiple layers .....		182
A.1	General .....	182
A.2	Refractive Index $n_i$ of all layers in Cover and Spacer Layers .....	182
A.3	Thickness variation of Transmission Stack .....	182
A.4	Thickness variations of Spacer Layers .....	182
A.5	Example of thickness calculation .....	183
Annex B (normative) Measurement of reflectivity .....		184
B.1	General .....	184
B.2	Calibration method .....	184
B.3	Measuring method .....	185
B.4	Procedure for compensating stray light effect from observed reflectivity .....	186
Annex C (normative) Measurement of scratch resistance of Cover Layer .....		189
C.1	General .....	189
C.2	Taber Abrasion test .....	189
Annex D (normative) Measurement of repulsion of grime by Cover Layer .....		191
D.1	General .....	191
D.2	Specifications of stamp .....	191
D.3	Preparation of ink .....	192
D.4	Preparation of ink pad .....	192
D.5	Using ink pad and stamp .....	193
Annex E (normative) Measurement of wobble amplitude .....		194
E.1	Measurement methods .....	194
E.2	Calibration of filters .....	197
Annex F (normative) Write-pulse waveform for testing .....		198
F.1	General write-pulse waveform .....	198
F.2	Extended N-1 write strategy .....	198
F.3	Extended N/2 write strategy .....	202
F.4	Definitions of pulse widths and rise and fall times .....	206
Annex G (normative) Optimum Power Control (OPC) procedure for media .....		208
G.1	General .....	208
G.2	Mathematical model for modulation versus power function .....	208
G.3	Procedure for determination of OPC parameters for media .....	210
Annex H (normative) HF signal Pre-processing for i-MLSE(Integrated-Maximum Likelihood Sequence Error Estimation) measurements .....		211
H.1	General .....	211
H.2	General implementation of i-MLSE measurement system .....	211
H.3	Specifications of Analogue filters (HPF and LPF) .....	211

H.4	Specifications of A/D Converter .....	212
H.5	Specifications of offset canceller .....	212
H.6	Specifications of Auto Gain Controller (AGC) .....	212
H.7	Specifications of Interpolator .....	213
H.8	Specifications of Phase Locked Loop .....	215
H.9	Specifications of Digital Equalizer .....	215
H.10	Specifications of Adaptive Equalizer .....	216
H.11	Specifications of Viterbi detector .....	217
H.12	Description of i-MLSE(Integrated - Maximum Likelihood Sequence Error Estimation) .....	217
H.12.1	General .....	217
H.12.2	General implementation of i-MLSE detection units .....	217
H.12.3	Pattern Detector .....	218
H.12.4	Metric Difference Calculator .....	219
H.12.5	Error rate estimation .....	220
H.12.6	i-MLSE calculation .....	223
<b>Annex I (normative) Measurement procedures .....</b>		<b>224</b>
I.1	General .....	224
I.2	Initial adjustments of Reference drive .....	224
I.3	i-MLSE measurement .....	224
I.4	Modulated amplitude measurements .....	224
I.5	Measurements of Resolution I3pp / I8pp .....	225
I.6	Measurement of Modulation I8pp / I8H and I3pp / I8H .....	226
I.7	Asymmetry measurement .....	227
I.7.1	General .....	227
I.7.2	Sampling method .....	227
I.7.3	Level calculation block (Averaging method) .....	228
I.7.4	Asymmetry calculation .....	230
I.8	Measurement of light reflectivity .....	231
I.8.1	General .....	231
I.8.2	Measurement procedure of light reflectivity .....	231
I.9	Tracking-error signal measurements (PPnorm measurement procedure) .....	232
I.10	Residual error of axial tracking measurement procedure .....	233
I.11	Residual error of radial tracking measurement procedure .....	233
I.12	Random SER measurement .....	234
<b>Annex J (informative) Measurement of birefringence .....</b>		<b>235</b>
J.1	Principle of measurement .....	235
J.2	Measurements conditions .....	235
J.3	Example of measurement procedure .....	236
J.4	Interchangeability of measuring results .....	236
<b>Annex K (informative) Measurement of thickness of Cover Layer and Spacer Layer .....</b>		<b>237</b>
K.1	Focussing method .....	237
K.2	Interferometer method .....	237
<b>Annex L (informative) Measurement of impact resistance of Cover Layer .....</b>		<b>240</b>
L.1	General .....	240
L.2	Recommendation for drives .....	240
L.3	Measurements of impact resistance of Cover Layer .....	240
<b>Annex M (informative) Groove deviation and wobble amplitude .....</b>		<b>241</b>
M.1	Relation between NWS and wobble amplitude .....	241
M.2	Tolerance of NWS .....	241
<b>Annex N (informative) Guideline for write pulse adjustment using L-SEAT edge-shift .....</b>		<b>243</b>

N.1	General .....	243
N.2	General implementation of edge-shift detection system .....	243
N.2.1	Edge-shift evaluation unit .....	243
N.2.2	Analogue filters (HPF, LPF) .....	243
N.2.3	AD Converter .....	243
N.2.4	Offset canceller .....	243
N.2.5	Auto Gain Controller (AGC) .....	244
N.2.6	Interpolator .....	244
N.2.7	Phase Locked Loop .....	244
N.2.8	Digital Equalizer .....	244
N.2.9	Adaptive Equalizer .....	244
N.2.10	Viterbi detector .....	244
N.2.11	L-SEAT evaluation block .....	244
N.3	HF signal processing for L-SEAT .....	245
N.3.1	General .....	245
N.3.2	Definition of L-SEAT .....	245
N.3.3	Edge detection bit patterns .....	246
N.4	General implementation of L-SEAT evaluation block .....	249
N.5	General write pulse adjustment procedure .....	250
Bibliography .....		252